


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537715	<b>Applicant(s)/Patent Under Reexamination</b>  VON KAENEL ET AL.
	<b>Examiner</b>  Wu, Yicun	<b>Art Unit</b>  2165

SEARCHED			
Class	Subclass	Date	Examiner
707	3, 104.1	9/25/2007	yw
705	50,78	9/25/2007	yw

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search (double patenting)uspto, uspgpub, epo, jpo, ibmtech, Derwent, acm, ieee, citeseer, internet, Search stratagy attached	9/25/2007	yw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner